

<b>Search Notes</b> 	<b>Application/Control No.</b>	<b>Applicant(s)/Patent under Reexamination</b>
	10/687,149	MCCREA ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	Dinh Q. Nguyen	3752

SEARCHED			
Class	Subclass	Date	Examiner
239	159-170		
	172-176		
	722-754	5-26-05	✓ N
74	473.18	5-26-05	✓ N
212	261		
	272		
	245		
	250		
	195-204	5-26-05	✓ N
188	378	5-26-05	✓ N
267	136	5-26-05	✓ N
414	719		
	dig 417	5-26-05	✓ N
UPDATED	SEARCHED	12/23/05	✓ N

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
239	167		
	168		
	159	5-26-05	SN
212	245	5-26-05	SN
52	114	5-26-05	SN